

Application Serial No. 10/750,580  
Response dated September 22, 2006  
Reply to Office Action dated August 2, 2006

Amendments to Claims

This listing of claims will replace all prior versions and listing of claims in the application:

Listing of Claims

1. (Previously presented) An integrated package comprising:
  - a first wafer having a first surface;
  - a second wafer having a first surface bonded at a first perimeter to the first surface of the first wafer; and
  - a recess formed in the first surface of the first wafer between the first perimeter and a second perimeter situated within the first perimeter for a window situated within the second perimeter.
2. (Previously presented) The package of claim 1, further comprising a first bump pattern in the first surface of the first wafer within the second perimeter.
3. (Previously presented) The package of claim 2, further comprising a second bump pattern on a second surface of the first wafer.
4. (Previously presented) The package of claim 3, further comprising a seal between the first and second wafers at the first perimeter.
5. (Previously presented) The package of claim 4,

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wherein the seal comprises:

a spacer material; and  
a layer of malleable material.

6. (Previously presented) The package of claim 5,  
wherein the seal further comprises a layer of bondable  
material.

7. (Previously presented) The package of claim 6,  
further comprising structural supports in the recess of the  
first wafer.

8. (Previously presented) The package of claim 7,  
further comprising at least one pumpout opening in the  
first wafer.

9. (Previously presented) The package of claim 8,  
wherein the first and second wafers comprise silicon.

10-25. (Canceled)

26. (Withdrawn) An integral package comprising:  
a first wafer comprising:  
a seal along a first perimeter on a first surface  
of the first wafer; and  
a trench in the first surface of the first wafer  
along a second perimeter within the first  
perimeter; and

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a second wafer having a first surface bonded to the first wafer along the seal.

27. (Withdrawn) The package of claim 26, wherein the first wafer further comprises an anti-reflective pattern on the first surface.

28. (Withdrawn) The package of claim 27, wherein the first wafer further comprises at least one vent hole and vent hole seal.

29. (Withdrawn) The package of claim 28, wherein the seal comprises a spacer material.

30. (Withdrawn) The package of claim 29, wherein the first wafer further comprises an anti-reflective pattern on a second surface.

31. (Withdrawn) An integrated package comprising:  
a first wafer having a first surface;  
a second wafer having a first surface bonded at a first perimeter to the first surface of the first wafer;  
a recess formed in the first surface of the first wafer in a second perimeter situated within the first perimeter;  
structural supports in the recess of the first wafer;  
a first bump pattern in the first surface of the first

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wafer within the second perimeter;  
a second bump pattern on a second surface of the first  
wafer; and  
a seal between the first and second wafers at the  
first perimeter; and  
wherein the seal comprises:  
a spacer material;  
a layer of malleable material; and  
a layer of bondable material.

32. (Withdrawn) The package of claim 31, further  
comprising at least one pumpout opening in the first wafer.

33. (Withdrawn) The package of claim 32, wherein the  
first and second wafers comprise silicon.

34. (Withdrawn) An integrated package comprising:  
a first wafer having a first surface;  
a second wafer having a first surface bonded at a  
first perimeter to the first surface of the first  
wafer;  
a recess formed in the first surface of the first  
wafer in a second perimeter situated within the  
first perimeter; and  
structural supports in the recess of the first wafer;

35. (Withdrawn) The package of claim 34, further  
comprising a seal between the first and second wafers at

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the first perimeter.

36. (Withdrawn) The package of claim 35, further comprising at least one pumpout opening in the first wafer.

37. (Withdrawn) The package of claim 36, further comprising a first bump pattern in the first surface of the first wafer within the second perimeter.

38. (Withdrawn) The package of claim 37, further comprising a second bump pattern on a second surface of the first wafer.

39. (Withdrawn) The package of claim 38, wherein the first and second wafers comprise silicon.

40. (Withdrawn) An integrated package comprising:  
a first wafer having a first surface;  
a second wafer having a first surface bonded at a  
first perimeter to the first surface of the first  
wafer;  
a recess formed in the first surface of the first  
wafer in a second perimeter situated within the  
first perimeter; and  
a first bump pattern on a second surface of the first  
wafer.

41. (Withdrawn) The package of claim 40, further

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comprising a seal between the first and second wafers at the first perimeter.

42. (Withdrawn) The package of claim 41, further comprising structural supports in the recess of the first wafer.

43. (Withdrawn) The package of claim 42, further comprising at least one pumpout opening in the first wafer.

44. (Withdrawn) The package of claim 43 a second bump pattern on a first surface of the first wafer.

45. (Withdrawn) The package of claim 44, wherein the first and second wafers comprise silicon.

46. (Withdrawn) An integrated package comprising:  
a first wafer having a first surface;  
a second wafer having a first surface bonded at a first perimeter to the first surface of the first wafer;  
a recess formed in the first surface of the first wafer between the first perimeter and a second perimeter situated within the first perimeter for a window situated within the second perimeter;  
and  
at least one pumpout opening in the first wafer.

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47. (Withdrawn) The package of claim 46, further comprising structural supports in the recess of the first wafer.

48. (Withdrawn) The package of claim 47, further comprising a first bump pattern in the first surface of the first wafer within the second perimeter.

49. (Withdrawn) The package of claim 48, further comprising a second bump pattern on a second surface of the first wafer.

50. (Withdrawn) The package of claim 49, further comprising a seal between the first and second wafers at the first perimeter.

51. (Withdrawn) The package of claim 50, wherein the first and second wafers comprise silicon.